Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination SCHWARZ ET AL.	
10/759,415		
Examiner	Art Unit	
DANH C. LE	2617	

SEARCHED						
Class	Subclass	Date	Examiner			
455	436 438 439	8 27 06	DCL			
	439					
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	328					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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Interferen	nce Sovich	8/27/06	DOL		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search. (Check for double patenting) EAST Search updated. (US, USPUB, EPO, JPO, DERWEN	8 27 06	DCL.		
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